

**Notice of References Cited**

Application/Control No.

10/791,269

Applicant(s)/Patent Under  
Reexamination  
CHUNG ET AL.

Examiner

ROBERT HODGE

Art Unit

1729

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,994,926	02-2006	Ikeuchi et al.	429/7
*	B	US-2003/0165736	09-2003	Hiratsuka, Masaru	429/153
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

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	N	WO 01/99211 A1	12-2001	WIPO	Ikeuchi et al.	
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Definition of Substantially retrieved from Dictionary.com on 1-6-12
	V	Definition of Perpendicular retrieved from Dictionary.com on 1-6-12
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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